

High Voltage IGBT

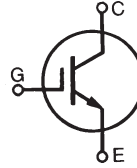
For Capacitor Discharge Applications

IXGK75N250
IXGX75N250

$$V_{CES} = 2500 \text{ V}$$

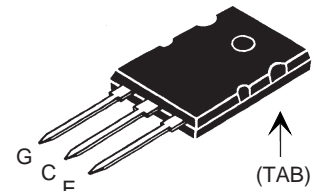
$$I_{C25} = 180 \text{ A}$$

$$V_{CE(sat)} \leq 2.3 \text{ V}$$

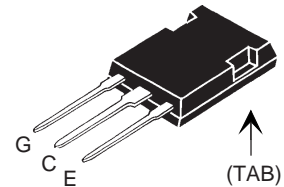


Symbol	Test Conditions	Maximum Ratings	
V_{CES}	$T_J = 25^\circ\text{C to } 150^\circ\text{C}$	2500	V
V_{CGR}	$T_J = 25^\circ\text{C to } 150^\circ\text{C}; R_{GE} = 1 \text{ M}\Omega$	2500	V
V_{GES}	Continuous	± 20	V
V_{GEM}	Transient	± 30	V
I_{C25}	$T_C = 25^\circ\text{C}$, chip capability	180	A
I_{C110}	$T_C = 110^\circ\text{C}$	75	A
$I_{L(RMS)}$	External lead capability	75	A
I_{CM}	$T_C = 25^\circ\text{C}$, $V_{GE} = 20 \text{ V}$, 1 ms	600	A
SSOA (RBSOA)	$V_{GE} = 15 \text{ V}$, $T_{VJ} = 125^\circ\text{C}$, $R_G = 3 \Omega$ Clamped inductive load	$I_{CM} = 300$ @ $0.8 V_{CES}$	A
P_C	$T_C = 25^\circ\text{C}$	735	W
T_J		-55 ... +150	$^\circ\text{C}$
T_{JM}		150	$^\circ\text{C}$
T_{stg}		-55 ... +150	$^\circ\text{C}$
T_L	1.6 mm (0.062 in.) from case for 10 s	300	$^\circ\text{C}$
T_{SOLD}	Plastic body for 10 s	260	$^\circ\text{C}$
F_c	Mounting force (PLUS247)	20..120/4.5..27	N/lb
M_d	Mounting torque (TO-264)	1.13/10	Nm/lb-in
Weight		PLUS247	6 g
		TO-264	10 g

TO-264 (IXGK)



PLUS247™ (IXGX)



G = Gate, C = Collector,
E = Emitter, TAB = Collector

Features

- High peak current capability
- Low saturation voltage
- MOS Gate turn-on -drive simplicity
- Rugged NPT structure
- Molding epoxies meet UL 94 V-0 flammability classification

Applications

- Capacitor discharge
- Pulser circuits

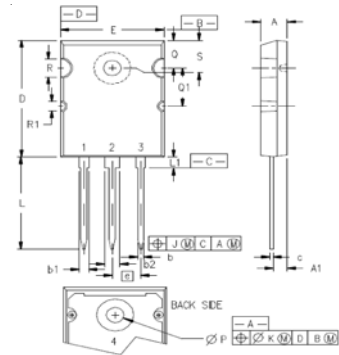
Advantages

- High power density
- Space savings
- Easy to mount

Symbol	Test Conditions	Characteristic Values ($T_J = 25^\circ\text{C}$ unless otherwise specified)		
		Min.	Typ.	Max.
BV_{CES}	$I_C = 1 \text{ mA}$, $V_{GE} = 0 \text{ V}$	2500		V
$V_{GE(th)}$	$I_C = 1 \text{ mA}$, $V_{CE} = V_{GE}$	3.0		5.0 V
I_{CES}	$V_{CE} = 0.8 \cdot V_{CES}$ $V_{GE} = 0 \text{ V}$ $T_J = 125^\circ\text{C}$			200 μA 5 mA
I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$			$\pm 200 \text{ nA}$
$V_{CE(sat)}$	$I_C = 75 \text{ A}$, $V_{GE} = 15 \text{ V}$			2.3 V
	$I_C = 150 \text{ A}$			3.2 V

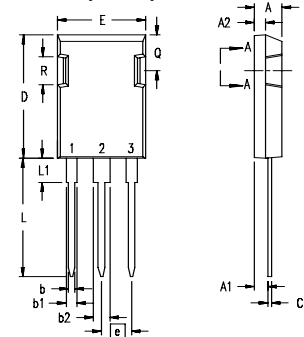
Symbol	Test Conditions	Characteristic Values ($T_J = 25^\circ\text{C}$ unless otherwise specified)		
		Min.	Typ.	Max.
g_{fs}	$I_C = 60\text{ A}; V_{CE} = 10\text{ V}$, Note 1	40	68	S
C_{ies}	$V_{CE} = 25\text{ V}, V_{GE} = 0\text{ V}, f = 1\text{ MHz}$		10.2	nF
C_{oes}			325	pF
C_{res}			116	pF
Q_g	$I_C = 75\text{ A}, V_{GE} = 15\text{ V}, V_{CE} = 0.5 V_{CES}$		400	nC
Q_{ge}			50	nC
Q_{gc}			160	nC
$t_{d(on)}$		Resistive load		50
t_{ri}	$I_C = 150\text{ A}, V_{GE} = 15\text{ V}$, Note 1 $V_{CE} = 1250\text{ V}, R_G = 1\ \Omega$		255	ns
$t_{d(off)}$			245	ns
t_{fi}			175	ns
R_{thJC}			0.17 $^\circ\text{C/W}$	
R_{thCS}		0.15		$^\circ\text{C/W}$

- Notes: 1. Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle, $d \leq 2\%$
 2. Additional provisions for lead-to-lead voltage isolation are required at $V_{CE} > 1200\text{V}$

TO-264 (IXGK) Outline


- 1 - GATE
 2, 4 - DRAIN (COLLECTOR)
 3 - SOURCE (EMITTER)

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.185	.209	4.70	5.31
A1	.102	.118	2.59	3.00
b	.037	.055	0.94	1.40
b1	.087	.102	2.21	2.59
b2	.110	.126	2.79	3.20
c	.017	.029	0.43	0.74
D	1.007	1.047	25.58	26.59
E	.760	.799	19.30	20.29
e	.215BSC		5.46 BSC	
J	.000	.010	0.00	0.25
K	.000	.010	0.00	0.25
L	.779	.842	19.79	21.39
L1	.087	.102	2.21	2.59
$\varnothing P$.122	.138	3.10	3.51
Q	.240	.256	6.10	6.50
Q1	.330	.346	8.38	8.79
$\varnothing R$.155	.187	3.94	4.75
$\varnothing R1$.085	.093	2.16	2.36
S	.243	.253	6.17	6.43

PLUS247™ (IXGX) Outline


- Terminals: 1 - Gate
 2 - Drain (Collector)
 3 - Source (Emitter)
 4 - Drain (Collector)

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
A	4.83	5.21	.190	.205
A ₁	2.29	2.54	.090	.100
A ₂	1.91	2.16	.075	.085
b	1.14	1.40	.045	.055
b ₁	1.91	2.13	.075	.084
b ₂	2.92	3.12	.115	.123
C	0.61	0.80	.024	.031
D	20.80	21.34	.819	.840
E	15.75	16.13	.620	.635
e	5.45 BSC		.215 BSC	
L	19.81	20.32	.780	.800
L1	3.81	4.32	.150	.170
Q	5.59	6.20	.220	0.244
R	4.32	4.83	.170	.190

PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

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IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents:

4,835,592	4,931,844	5,049,961	5,237,481	6,162,665	6,404,065 B1	6,683,344	6,727,585	7,005,734 B2	7,157,338 B2
4,850,072	5,017,508	5,063,307	5,381,025	6,259,123 B1	6,534,343	6,710,405 B2	6,759,692	7,063,975 B2	
4,881,106	5,034,796	5,187,117	5,486,715	6,306,728 B1	6,583,505	6,710,463	6,771,478 B2	7,071,537	

Fig. 1. Output Characteristics @ 25°C

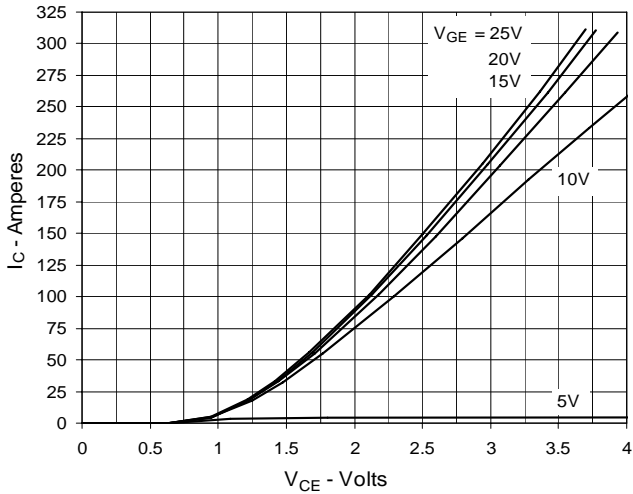


Fig. 2. Output Characteristics @ 125°C

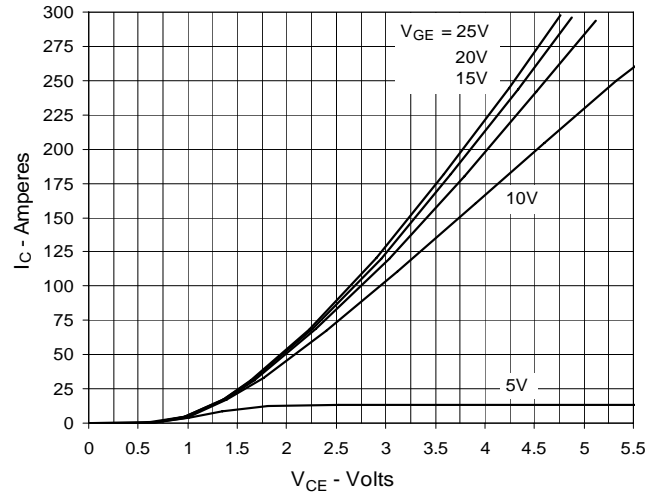


Fig. 3. Dependence of $V_{CE(sat)}$ on Junction Temperature

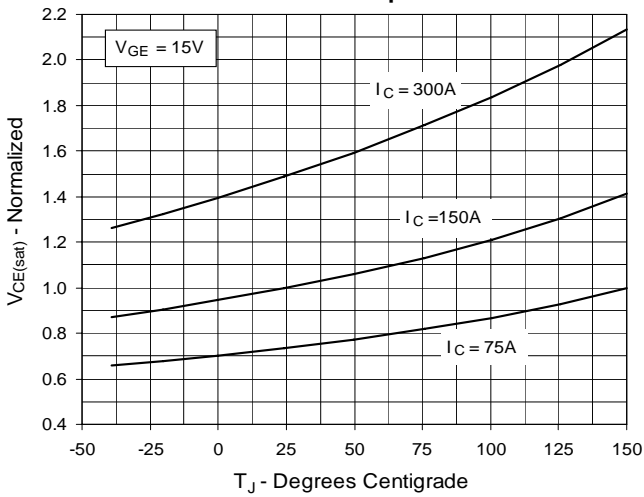


Fig. 4. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage

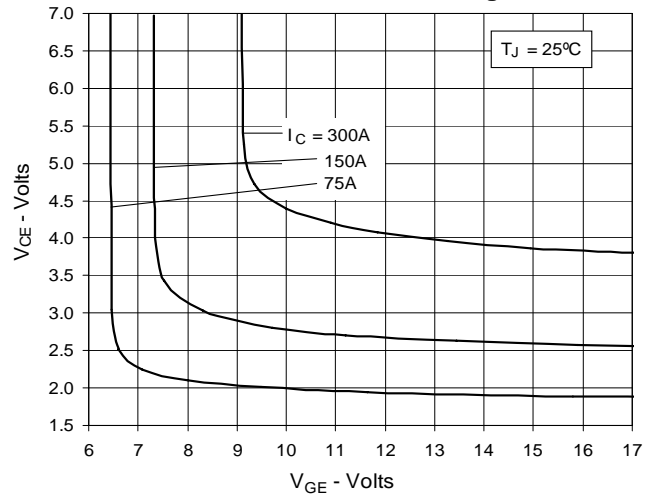


Fig. 5. Input Admittance

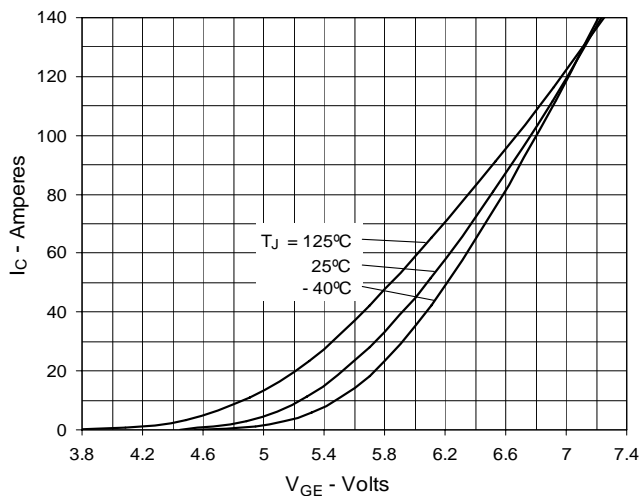


Fig. 6. Transconductance

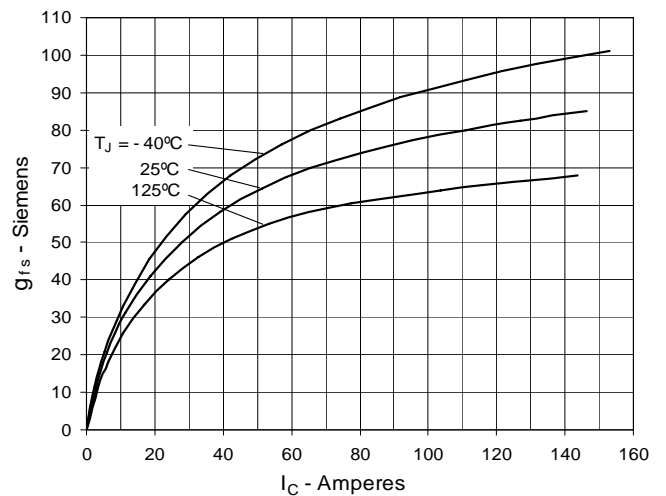


Fig. 7. Resistive Turn-on Rise Time vs. Junction Temperature

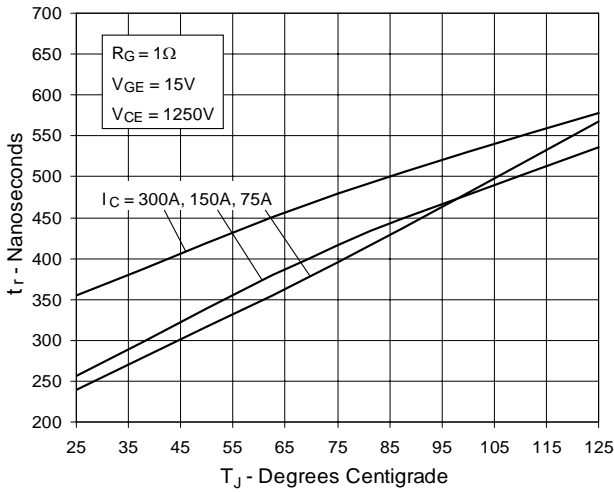


Fig. 8. Resistive Turn-on Rise Time vs. Collector Current

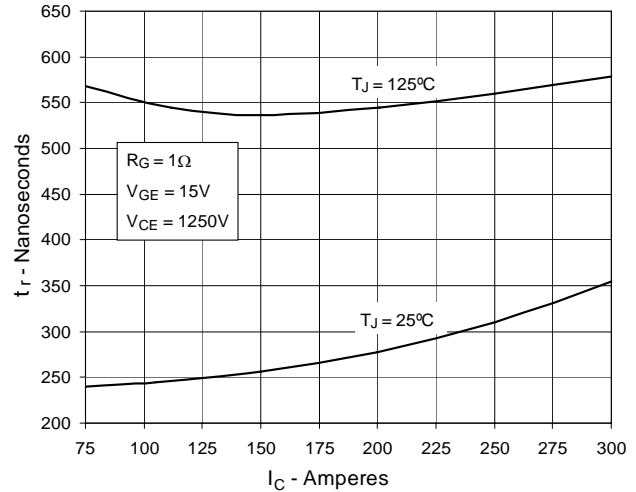


Fig. 9. Resistive Turn-on Switching Times vs. Gate Resistance

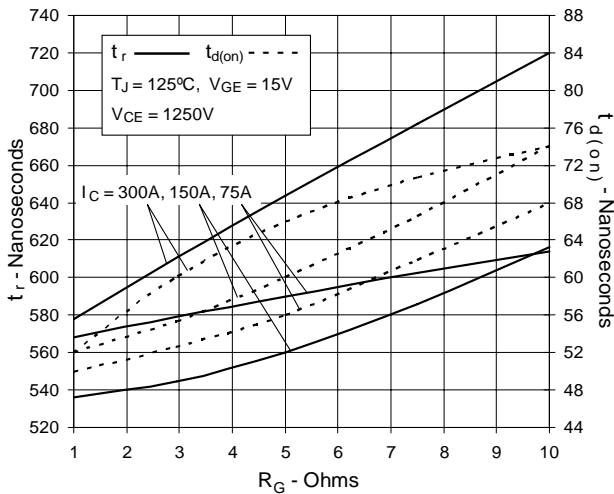


Fig. 10. Resistive Turn-off Switching Times vs. Junction Temperature

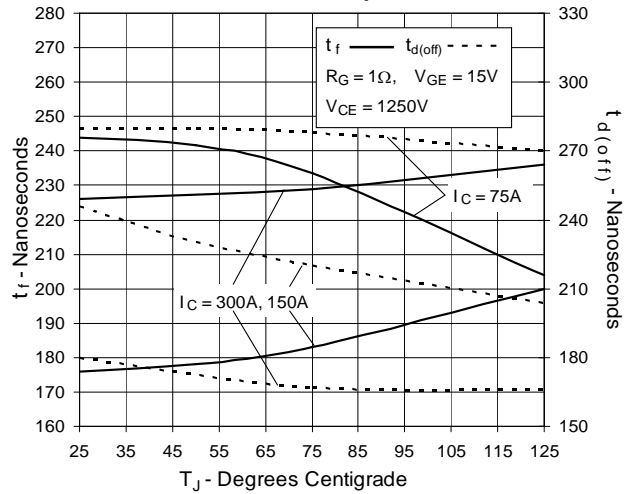


Fig. 11. Resistive Turn-off Switching Times vs. Collector Current

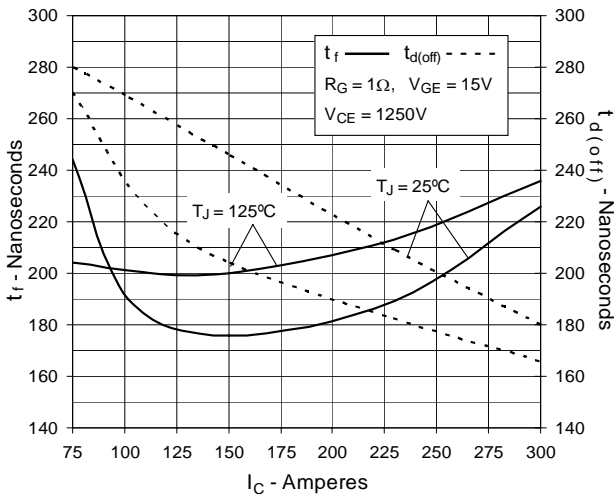


Fig. 12. Resistive Turn-off Switching Times vs. Gate Resistance

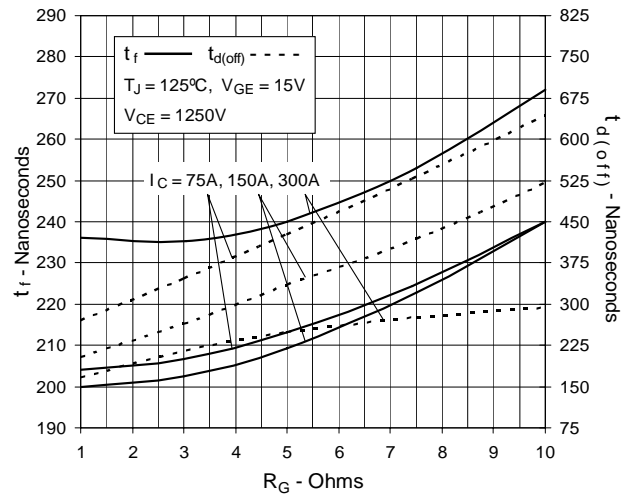


Fig. 13. Gate Charge

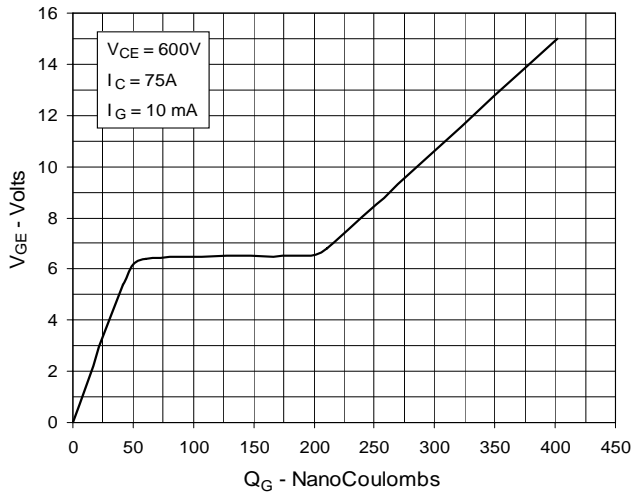


Fig. 14. Capacitance

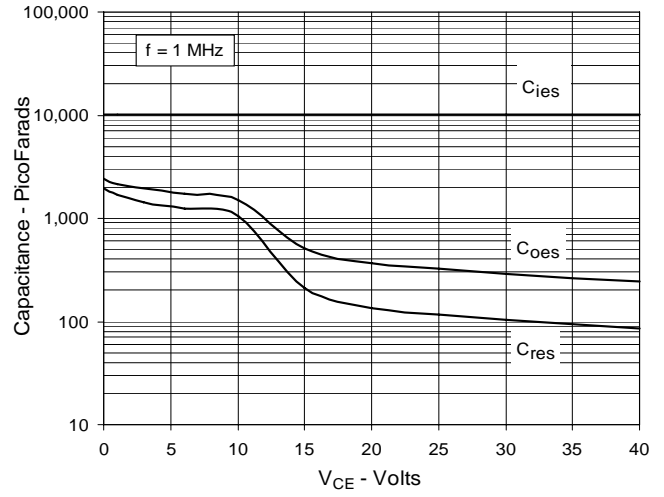


Fig. 15. Reverse-Bias Safe Operating Area

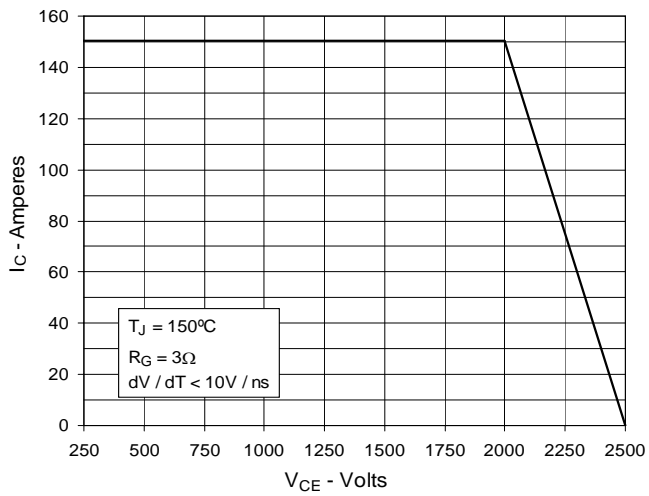


Fig. 16. Maximum Transient Thermal Impedance

